


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525598	<b>Applicant(s)/Patent Under Reexamination</b>  VAN DE LOGT ET AL.
	<b>Examiner</b>  Christine T Tu	<b>Art Unit</b>  2117

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(714/724-728,731,733-736,741-742,819-821,25,27,30,32), (324/763) and text (see history)	7/1/2008	CTLT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner